

Experiment 2



Bachelor of Technology
Department of Electrical Engineering

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Objective

Determine the small-signal DC parameters of Diode, BJT, and MOSFET devices using both hand calculations and simulation.

1 Diode

Parameters and Formulae Used

- Shockley Equation

$$I_D = I_s \left(e^{\frac{V_D}{nV_T}} - 1 \right)$$

- **Dynamic Resistance** r_d

- Hand Calculation: $r_d = \frac{\eta V_T}{I_D}$
- Experimental: $r_d = \frac{\partial V_D}{\partial I_D}$ (from graph)

1.1 Plots

Operating Point values used,

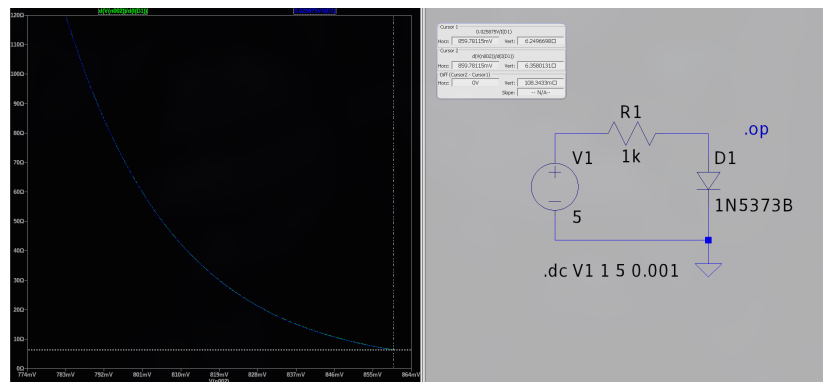
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--- Operating Point ---
V(n002):      0.859781      voltage
V(n001):      5            voltage
I(V1):        -0.00414022   device_current
I(R1):        -0.00414022   device_current
I(D1):        0.00414022    device_current

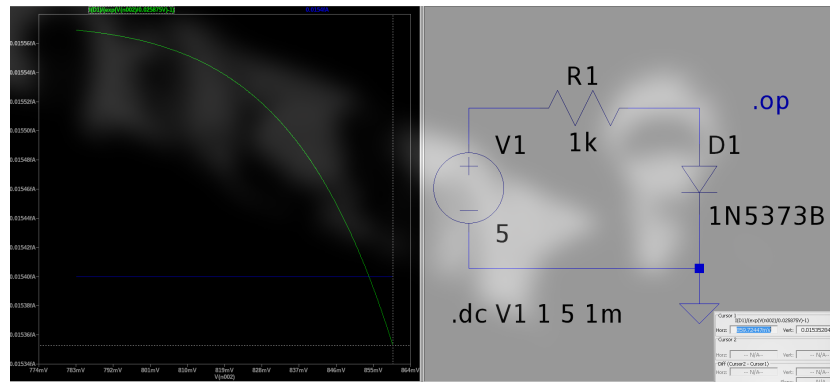
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I_s of the diode chosen is $0.0154 fA$

1. r_d



2. I_s



Experimental vs Theoretical Results

Parameter	Experimental	Theory	Error (%)
r_d	6.358 $k\Omega$	6.249 $k\Omega$	1.71
I_s	0.01535 fA	0.0154 fA	2.27

2 BJT

Parameters and Formulae Used

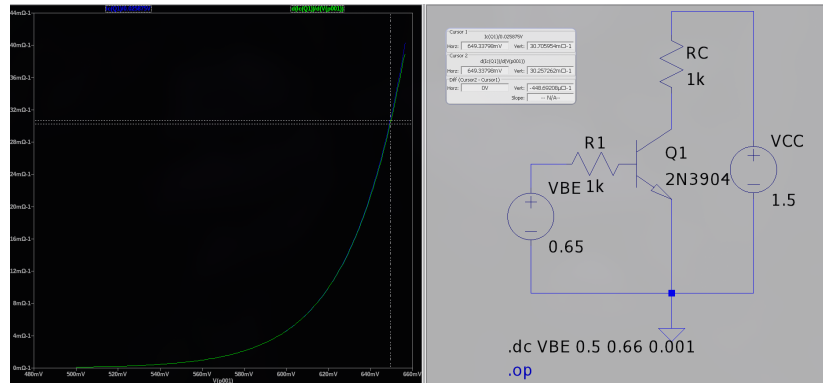
- **Transconductance g_m**
 - Hand Calculation: $g_m = \frac{I_C}{\eta V_T}$
 - Experimental: $g_m = \frac{\partial I_C}{\partial V_{BE}}$ (from graph)
- **Input Resistance r_π**
 - Hand Calculation: $r_\pi = \frac{\eta V_T}{I_B}$
 - Experimental: $r_\pi = \frac{\partial V_{BE}}{\partial I_B}$ (from graph)
- **Current Gain β**
 - Hand Calculation: $\beta = \frac{I_C}{I_B}$
 - Experimental: $\beta = \frac{\partial I_C}{\partial I_B}$
- **Output Resistance r_o**
 - Hand Calculation: $r_o = \frac{1}{\lambda I_C}$
 - Experimental: $r_o = \frac{\partial V_{CE}}{\partial I_C}$ (from graph)

2.1 Plots

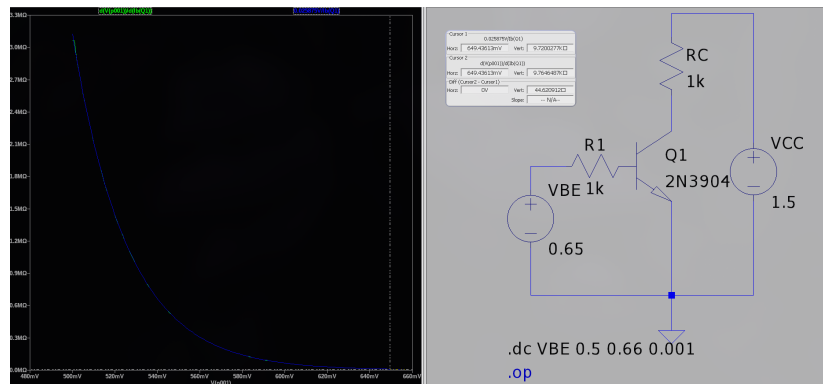
Operating Point values used, For the BJT chosen, $\eta = 1$

--- Operating Point ---		
V(p001):	0.647526	voltage
V(n003):	0.65	voltage
V(n002):	0.758491	voltage
V(n001):	1.5	voltage
Ic(Q1):	0.000741509	device_current
Ib(Q1):	2.47353e-06	device_current
Ie(Q1):	-0.000743983	device_current
Is(Q1):	0	device_current
I(VCC):	-0.000741509	device_current
I(R1):	-2.47353e-06	device_current
I(RC):	0.000741509	device_current
I(VBE):	-2.47353e-06	device_current

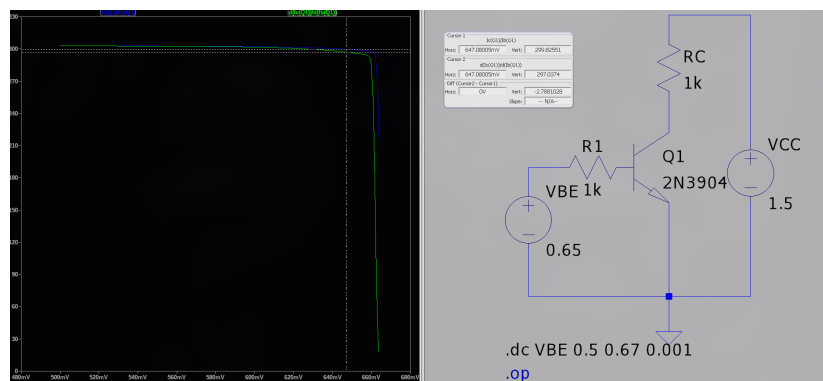
1. g_m



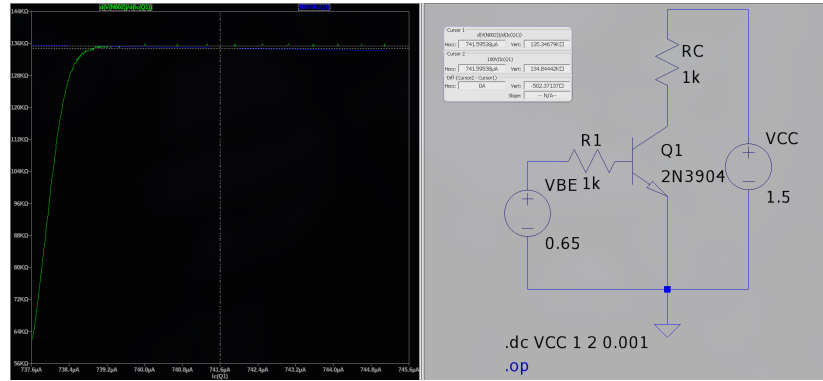
2. r_π



3. β



4. r_0



Experimental vs Theoretical Results

Parameter	Experimental	Theory	Error (%)
g_m	$30.257 \text{ m}\Omega^{-1}$	$30.705 \text{ m}\Omega^{-1}$	1.45
r_π	$9.764 \text{ k}\Omega$	$9.720 \text{ k}\Omega$	0.45
β	297.304	299.825	0.93
r_0	$135.346 \text{ k}\Omega$	$134.844 \text{ k}\Omega$	0.37

3 MOSFET

Parameters and Formulae Used

- Transconductance g_m
 - Hand Calculation: $g_m = \frac{2I_D}{V_{GS} - V_{TH}}$
 - Experimental: $g_m = \frac{\partial I_D}{\partial V_{GS}}$ (from graph)
- Output Resistance r_o
 - Hand Calculation: $r_o = \frac{(\frac{1}{\lambda} + V_{GS})}{I_D} \approx \frac{1}{\lambda I_D}$
 - Experimental: $r_o = \frac{\partial V_{DS}}{\partial I_D}$ (from graph)

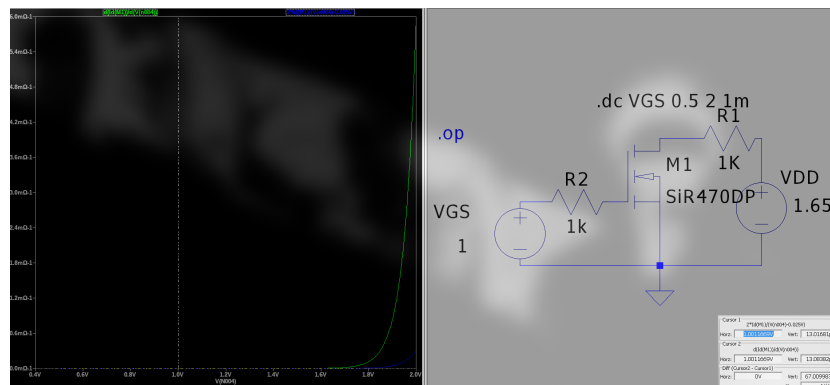
3.1 Plots

Operating Point values used, For the chosen MOSFET, $\lambda = \frac{1}{V_A} = 1000, V_{TH} =$

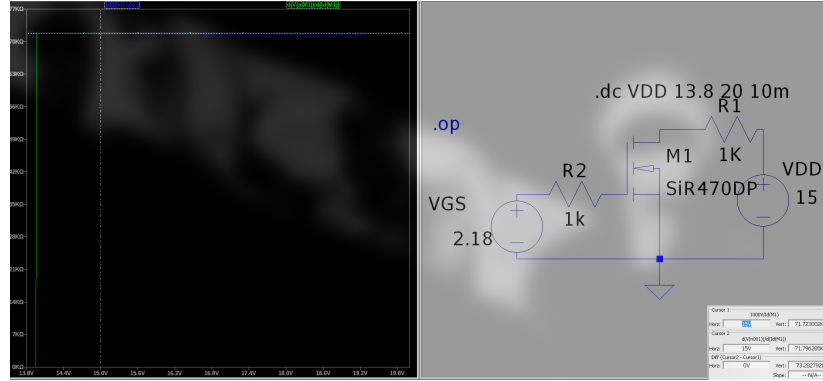
--- Operating Point ---		
V(n004):	1	voltage
V(n002):	1.65	voltage
V(n001):	1.65	voltage
V(n003):	1	voltage
Id(M1):	1.57289e-09	device_current
Ig(M1):	-1.54195e-09	device_current
Is(M1):	-3.09387e-11	device_current
I(VDD):	-3.54647e-11	device_current
I(R2):	1.45217e-16	device_current
I(VGS):	1.45283e-16	device_current
I(R1):	3.54647e-11	device_current

0.025V

1. g_m



2. r_0



Experimental vs Theoretical Results

Parameter	Experimental	Theory	Error (%)
g_m	$13.083 \text{ p}\Omega^{-1}$	$13.016 \text{ p}\Omega^{-1}$	0.51
r_0	$71.796 \text{ k}\Omega$	$71.723 \text{ k}\Omega$	0.1

4 Conclusion

The experiment to conduct small signal analysis and verify the parameters with hand calculations was successful with a maximum error of 5%.